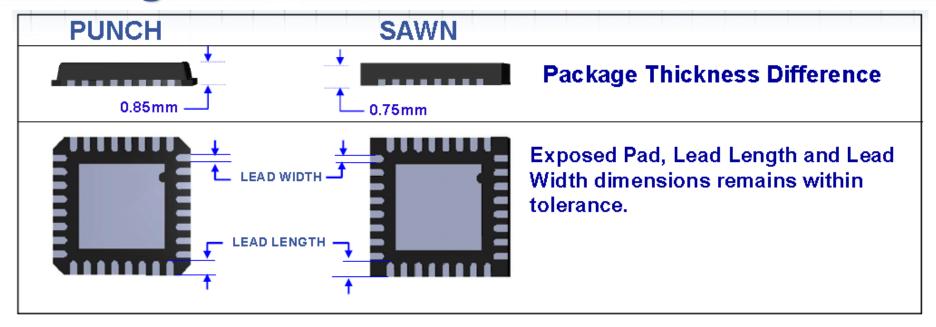
Bill of Materials and Package Configuration

Material	FROM	то	Remarks	
Waterial	Amkor - Korea	Amkor - Philippines		
Die Attach	Ablestik 8290	Ablestik 3230	Same Resin Base	
Wire	Au	Au	Same	
Mold Compound	Sumitomo G700	Sumitomo G700	Same	
Leadframe	C194	C194	Same	
<u>Package</u> : Side			<u>Punch</u> : Flange <u>Sawn</u> : Square	
Тор	ANALOG DEVICES DEVICE PUNCH	ANALOG DEVICES DEVICE SAWN	Sawn: • Pin 1 is Laser Marked • Square Edge	
Bottom			Same Foot Print	



Package Dimensions



Lead Count	Lead Pitch (mm)	Punch LFCSP POD	Sawn LFCSP POD	Exposed Pad Size (mm)
16	0.8	CP 16-6	CP 16-31	3.1 x 3.1
20	0.65	CP 20-5	CP 20-9	3.1 x 3.1
	0.5	CP 32-8	CP 32-21	2.7 x 2.7
5 x 5		CP 32-2	CP 32-7	3.1 x 3.1
32		CP 32-3	CP 32-13	3.3 x 3.3
		CP 32-4	CP 32-11	3.5 x 3.5
	Count 16	Count (mm) 16 0.8 20 0.65	Count (mm) POD 16 0.8 CP 16-6 20 0.65 CP 20-5 32 CP 32-8 CP 32-2 CP 32-3	Count (mm) POD POD 16 0.8 CP 16-6 CP 16-31 20 0.65 CP 20-5 CP 20-9 32 CP 32-8 CP 32-21 CP 32-2 CP 32-7 CP 32-3 CP 32-13

Qualification Results Summary of Sawn LFCSP Package at Amkor Philippines (ATP)

QUALIFICATION RESULTS					
Test	Conditions	Sample Size	Results		
Temperature/Humidity Biase (THB)*	JEDEC JESD22-A101	3 x 77	Passed		
Temperature Cycle (TC)*	JEDEC <i>JESD22-A104</i>	3 x 77	Passed		
Autoclave (AC)*	JEDEC <i>JESD22-A10</i> 2	3 x 77	Passed		
Solder Heat Resistance (SHR)*	JEDEC/IPC <i>J-STD-020</i>	3 x 11	Passed		
High Temperature Storage Life (HTSL)	JEDEC <i>JESD22-A103</i>	3 x 77	Passed		
Field-Induced Charged Device Model (FICDM)	JEDEC JESD22-C101	1 x 18	Passed		

^{*} These samples were subjected to preconditioning (per J-STD-020 Level 3) prior to the start of the stress test. Level 3 preconditioning consists of the following: 1. Bake – 24 hours at 125°C; 2. Soak – unbiased soak for 192 hours at 30°C, 60%RH; 3. Reflow – three passes through a reflow oven with a peak temperature of 260°C. TC samples were subjected to wire-pull test after 500 cycles with results within specification limits.